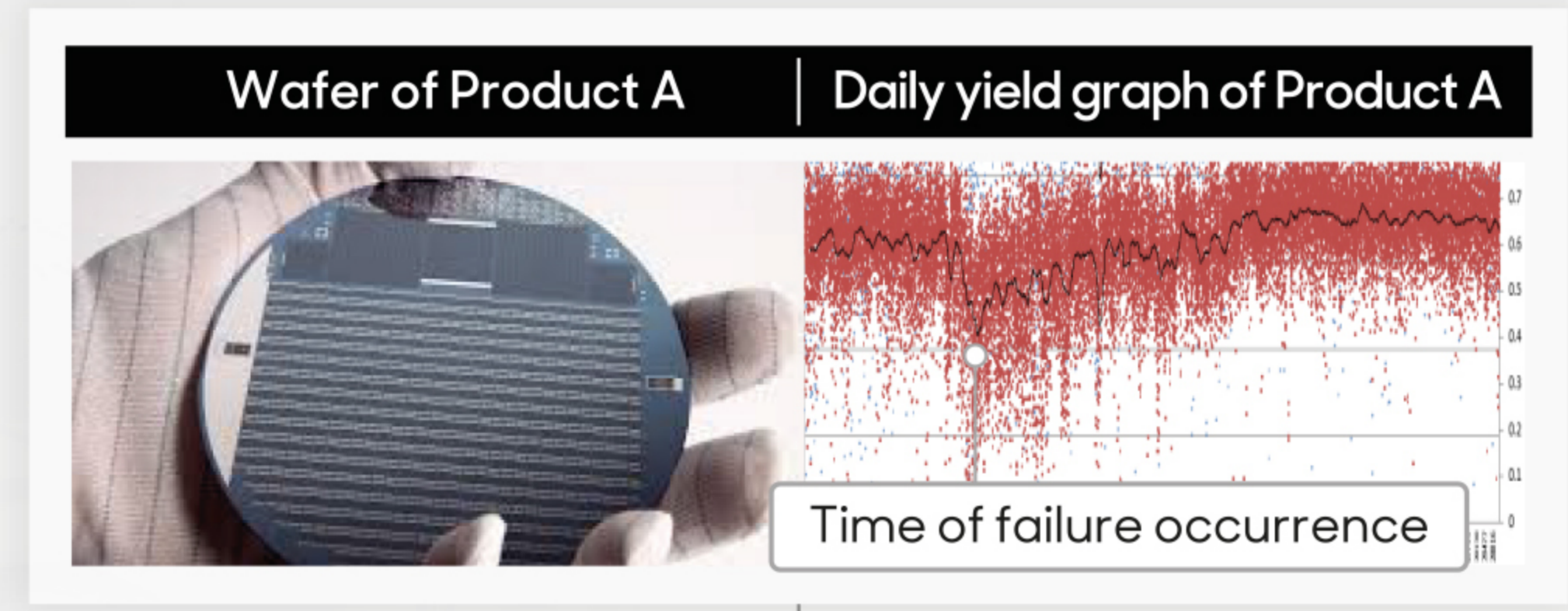


Nexplant Analytics Use Case

Detect failures right away

After coming to office, engineer discovered an abnormal yield drop in the wafer being fabricated the previous day. So engineer analyzed the cause of yield loss by obtaining equipment and quality data amounting to 1 year of the same failure causing product and took appropriate measures.



Nexplant Analytics

- ✓ Failure causing parameter analysis
- ✓ Unique profile analysis

